Structural diversity and electronic properties in potassium silicides

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Abstract

Stable potassium silicides in the complete compositional landscape were systematically explored up to 30 GPa using variable-composition evolutionary structure prediction method. The results show that K4Si, K3Si, K5Si2, K2Si, K3Si2, KSi, KSi2, KSi3 and K₈Si₄₆ have their stability fields in the phase diagram. The spatial dimensional diversity of polymerized silicon atoms (0D 'isolated' anion, dimer, Si₄ group, 1D zigzag chain, 2D layer, and 3D network) under the potassium sublattice were uncovered as silicon content increases. Especially, the 2D layered silicon presents interestingly a variety of shapes, such as the '4+6' ring, '4+8' ring, and 8-membered ring. K-Si bonding exhibits a mixed covalency and ionicity, while Si-Si bonding is always of covalent character. Semiconductivity or metallicity mainly depends on the form of sublattices and K:Si ratio, which allows us to find more semiconductors in the Si-rich side when closedshell K cations are encompassed by polymerized Si. The semiconducting silicides present strong absorption in the infrared and visible light range. These findings open up the avenue for experimental synthesis of alkali metal-IVA compounds and potential applications as battery electrode materials or photoelectric materials.

I. INTRODUCTION

The family of alkali metal- and alkaline earth metal-IVA compounds have been attracting considerable attentions recently, not only because of their various extraordinary properties and potential applications, but also because that they can actually be precursors for novel group-IVA allotropes that cannot be prepared in other ways¹⁻⁹. The polymerized behavior of carbon or silicon atoms under the framework of alkali metal- and alkaline earth metal under pressure has been widely discussed by combined theoretical and experimental studies^{3-5,10-15}. A calcium carbide with a high carbon content could act as a precursor to fabricate a variety of three-dimensional structures of carbon by removing metal atoms^{11,16}. This idea has been successfully applied to design novel allotropes of silicon. Using Na₄Si₂₄ synthesized in the Na-Si binary system under high pressure, Kim *et al* prepared an open-framework allotrope of silicon, Si₂₄, a semiconductor with a quasi-direct bandgap.⁶ Subsequently, other silicon allotropes were consecutively suggested by removing the guest-free alkali metal atoms theoretically.^{17, 18} The success in these systems strongly motivates us to further the search and design of new materials in other alkaline metal-IVA systems.

Although there are plenty of theoretical and experimental studies on the Li-Si ^{8, 9}. ¹⁹⁻³¹ and Na-Si system ^{6, 17-18}, study on the K-Si system is very limited. For K-Si system, there are three known phases at ambient conditions: KSi ³²⁻³⁴, K₁₂Si₁₇ ³⁵, and K₈Si₄₆ ³⁶. KSi crystallizes in a cubic KGe-type structure (space group *P*-43*n*, 32 molecules per unit cell, i.e., Z=32), in which both K and Si atoms form tetrahedrons. ^{32, 33} KSi can be written as K₄Si₄ because of the existence of cluster Si₄⁴⁻. KSi can absorb hydrogen to form the potassium silanide, KSiH₃, a reversible hydrogen storage material. ³⁷ The reported high-pressure form of tetragonal KSi is of the NaPb type (space group $I4_1/acd$, Z=32). ³⁴ K₁₂Si₁₇ contains isolated Si₉⁴⁻ clusters and is a potential precursor candidate for silicon clusters in solution. ³⁵ In addition, some studies on the K-Si system focused on exploring the pressure-induced isostructural volume collapse observed during the phase transition of type I silicon-clathrate. ³⁸⁻⁴⁰ K₈Si₄₆ exhibits an unusual volume collapse transition at about 15 GPa while apparently retaining the same cubic clathrate crystal structure, which is followed by a pressure-induced amorphization observed in K₈Si₄₆ indicate that there are thermodynamically stable new compounds in the K-Si system. Therefore, it is quite necessary to perform a complete phase diagram search for stable compounds in the K-Si system by using fruitful crystal structural prediction methods.

In this work, the thermodynamic phase diagram of K-Si system in the range of 0-30 GPa is investigated by means of evolutionary algorithm 41,42 in combination with first-principles total energy calculations. To obtain thermodynamically stable stoichiometries, we perform variable composition structural search in the whole compositional space, which has successfully uncovered novel compounds in many systems.^{13,43} The thermodynamic stability field of predicted compounds is determined via free energy calculations under harmonic approximation. Besides, electronic structures and bonding characteristics are systematically discussed. We find that the Sirich compounds are semiconductors except for *Fd-3m*-KSi₂ and P-1-KSi, while the K-

rich compounds are all metals except for P-1-K₃Si₂ and R-3m-K₄Si. The P-1-K₃Si₂ and R-3m-K₄Si are semiconductors with an indirect band gap.

II. COMPUTATIONAL METHODS

Searches for stable structures in the K-Si system under compression were carried out using the evolutionary algorithm USPEX code ^{41, 42} coupled with the VASP package ⁴⁴ based on DFT within the generalized gradient approximation with the exchangecorrelation functional of Perdew-Burke-Ernzerhof (PBE)⁴⁵. The electron-ion interaction was depicted by means of projector-augmented wave (PAW) with $3p^63d^1$ and $3s^23p^2$ as valence electrons for K and Si, respectively. The most interesting structures were further relaxed with a basis set cutoff of 350 eV. The enthalpy of formation per atom of $K_n Si_m$ is defined as $\Delta H_f(K_n Si_m) = [H(K_n S_m) - nH(K) - mH(Si)]/(n$ + m), where all enthalpies H are given at the same pressure and zero temperature. Phonon calculations were performed to determine the dynamical stability of the predicted structures by using the finite displacement approach as implemented in the Phonopy code.^{46, 47} The lattice dynamic properties were also checked by the QUANTUM ESPRESSO package ⁴⁸ using PAW pseudopotentials with a cutoff energy of 50 Ry. The electron localization function (ELF)⁴⁹ was used to analyze the chemical bonds.

III. RESULTS AND DISCUSSION

A. Thermodynamic phase diagram

The evolutionary algorithm USPEX,^{41,42} that can simultaneously find stable stoichiometries and the corresponding structures in multicomponent systems, was used

to predict stable K-Si compounds and their structures. In these calculations, all stoichiometries were allowed (with the constraint that the total number of atoms in the unit cell being below 32 atoms), and calculations were performed at 5 GPa, 10 GPa, 20 GPa, and 30 GPa. Pressure-composition phase diagram of the K-Si system is given in Fig. 1a. In our calculations, we also included an identified phase K₈Si₄₆.^{38, 39} As shown in Fig. 1a, the K-Si compounds locating on the convex hull are thermodynamically stable against decomposition to any other binaries or the elements, while the compounds above the convex hull are metastable. Consequently, we found that K₄Si, K₃Si, K₅Si₂, K₂Si, K₃Si₂, KSi, KSi₂, KSi₃, and K₈Si₄₆ have thermodynamic stability fields on the phase diagram: K₄Si, stable above 9 GPa; K₃Si, stable above 20 GPa; K₅Si₂, stable above 6.5 GPa to 28.5 GPa; K₂Si, stable above 12.5 GPa; K₃Si₂, stable above 15 GPa to 27.5 GPa; KSi, stable from 0 to 22.5 GPa; KSi₂, stable above 18.5 GPa; KSi₃, stable from 2.5 to 19.5 GPa; K₈Si₄₆, stable from 0 to 17.5 GPa (see Fig. 1b). For all the newly predicted structures, calculated phonon dispersion curves confirmed their dynamical stability (see Fig. 2, Fig. S2 and Fig. S3).

As expected, we found that the upper limit of stability domain of K₈Si₄₆ (~17.5 GPa) agrees well with its isostructural phase transition pressure (~15 GPa) observed experimentally.³⁸ Therefore, one can conclude that the volume collapse and amphormization of K₈Si₄₆ are closely related to the change of thermodynamic stability under strong compression. Theoretically, K₈Si₄₆ decomposed to KSi₃ (from17.5 to 19.0 GPa) and *sH*-silicon (simple hexagonal phase of silicon) or KSi₂ (above 20 GPa) and *sH*-silicon above 17.5 GPa.

In addition, we found that some K-Si compounds can undergo a series of structural phase transitions within the considered pressure range (see Fig. 1b). The *P*-1-K₂Si transformed into the orthorhombic *Cmcm*-K₂Si at 12.8 GPa. In the case of KSi, the *P*-43*n*-KSi transformed to the *I*4₁/*acd*-KSi at 2.2 GPa, and to the *C*2/*c*-KSi at 11 GPa, followed by the *P*-1-KSi at 24.5 GPa (see Fig. S1). The monoclinic *C*2/*m*-KSi₂ transformed into the cubic *Fd*-3*m*-KSi₂ at 18.5 GPa.

B. Dynamical and structural properties

To confirm the dynamical stability of the predicted compounds, we calculated the phonon spectra along the high-symmetry directions in Brillouin zone (BZ) at corresponding pressures. One can conclude that the predicted compounds together with the well-known K₈Si₄₆ are dynamically stable within their thermodynamic-stability pressure domain since there is no imaginary frequency in the calculated phonon spectra, as shown in Fig. 2, Fig. S2 and Fig. S3. From the partial atomic phonon density of states (PHDOS), Si atoms almost dominate the whole frequency range, but with a slight emphasis relatively on the high-frequency modes. Whereas K atoms dominate relatively the low frequency modes because of its relatively large atomic mass. For the K-rich side, including KSi, there are larger frequency gaps in the optical branches part because of the peculiar polymerization form of silicon atoms (0D, 1D and 2D, see Fig. 2, Fig. 3, Fig. S2 and Fig. S3), which in nature origins from the chemical bonding network topology, i. e., links between the Si sublattice and K sublattice. Generally, PHDOS of Si hovers over the high-frequency region if there is direct bonding of covalent character between Si atoms, which propagates into the lower-frequency region if there is direct bonding of ionic character between Si and K or Si is isolated by K.

All stable structures of K-Si system are plotted in Fig. 3. The equilibrium lattice parameters of the predicted phases at examined pressures are given in Table S1. We find that the silicon sublattices within all predicted silicide phases have a close correlation with K:Si ratio (see Fig. 3). Similar to our previous study on Ca-C system,^{3,4,13} the polymerization of silicon atoms underwent great changes with the increasing silicon content, that is, isolated silicon atoms are polymerized, in turn, into Si₂ dumbbells, Si₄ groups, chains, layers, and three-dimensional framework structures (see Fig. 3 and Fig. 4). Let us discuss the predicted phases in order of the increasing silicon content.

K4Si. It is thermodynamically stable (metastable between 4 GPa and 9 GPa) above 9 GPa (space group *I4/m* (Z=2)). The tetragonal K4Si with *I4/m* symmetry (see Fig. 3a) is thermodynamically stable up to about 16 GPa. The 'isolated' Si atoms occupy the crystallographic 2*b* sites, while alkali metal atoms hold 8*h* sites (see supporting Table S1). The tetragonal structure of K4Si has been observed in Li₄C¹⁰ and has also been favored by highly compressed Li₄Si. ³¹ Above 16 GPa, the semi-metallic *I/4m*-K4Si gives way to the semiconducting *R*-3*m*-K4Si (see Fig. 3b), in which 'isolated' Si atom is surrounded by eight K atoms (i.e., eight-fold coordinated silicon).

K₃**Si**. Monoclinic structure of K₃Si (space group *C*2/*m*, Z=4, Fig. 3c) is predicted to be thermodynamically stable above 20 GPa (metastable one between 4.8 and 20 GPa). Both Si atoms and K atoms occupy the 4*i* sites (Table S1). Si-Si bond length in the 'isolated' dumbbell is 2.502Å at 6 GPa.

K₅**Si**₂. K₅**Si**₂ dominates the range of pressure from 6.5 GPa to 28.5 GPa, adopting *R*-3*m* symmetry (Z=1, Fig. 3d), in which Si atoms occupy the crystallographic 2*c* sites. The structural feature of *R*-3*m*-K₅Si₂ is identical to *R*-3*m*-Li₅Si₂³¹, in which the silicon dumbbell (bond length, 2.389 Å at 9 GPa) is arranged along the *c*-axis. It is noteworthy that a ratio of 5:2 is also favored in the Li-Sn ⁵⁰ and Ca-C systems ¹³. The results indicate that the component ratio of 5:2 is a favorable one for group IA-IVA or IIA-IVA compounds.

K₂**Si**. Triclinic *P*-1-K₂Si (Z=4, Fig. 3e) stabilizes in a narrow pressure range of 12.5 GPa-12.8 GPa. Structurally, it includes zigzag Si₄ groups in which the bond lengths are 2.31 Å and 2.35 Å and the bond angle is about 125.81° at 2.5 GPa. Upon compression, the triclinic *P*-1-K₂Si transforms into an orthorhombic *Cmcm*-K₂Si (Z=2, Fig. 3f) at 12.8 GPa. The Si atoms in *Cmcm*-K₂Si phase are aggregated into zigzag chains. It is surprising that there is an abnormal extension in Si-Si bond length compared to the low-pressure *P*-1 phase. At 12.8 GPa, the bond length of Si-Si in silicon atomic chains is about 2.522 Å and the Si-Si-Si angle is 113.99⁰.

K₃**Si**₂. K₃Si₂ crystallizes in the *P*-1 structure (Z=2, Fig. 3g) and is thermodynamically stable from 15 GPa to 27.5 GPa. Si atoms form a parallelogram with the bond lengths of 2.400 Å and 2.404 Å and the Si-Si-Si angle of 90.427° and 89.570° at 1.0 GPa.

KSi. KSi has three thermodynamically stable phases (*P*-43*n*, *I*4₁/*acd*, and *C*2/*c*). The well-known cubic *P*-43*n*-KSi 32 (Z=32, Fig. 3h) is reproduced in our structure searches at ambient pressure. The optimized lattice parameter (12.733 Å) agrees well

with experimental data (12.620 Å) $^{32, 33}$. Two nonequivalent Si atoms locate at the 24*i* (0.562, 0.073, 0.183) and 8e (0.568, 0.568, 0.568) sites, respectively. Si1 atoms form slightly distorted tetrahedrons with two different Si-Si bond lengths (2.428 Å and 2.447 Å) at ambient pressure, while Si2 atoms form regular tetrahedrons with bond length of 2.435 Å at ambient pressure (see Fig. 4h). We performed some component-fixed calculations (at the selected pressure points of 5 GPa and 10 GPa) with the constraint that the number of K₄Si₄ in the unit cell is up to 4 formulas (that is, at most 32 atoms in the unit cell). It turns out that the NaPb-type structure was reproduced in our searching. The NaPb-type structure (space group $I4_1/acd$), with isolated Si₄ tetrahedra surrounded by K atoms (see Fig. 3i), is thermodynamically stable at the pressure range from 2.2 GPa to 11 GPa. The predicted phase transition pressure of 2.2 GPa from P-43n phase to $I4_1/acd$ phase is in good agreement with the experimental data (about 4 GPa).³⁴ The tetragonal NaPb-type structure transformed into a monoclinic C2/c structure at the pressure of 11 GPa, in which the silicon tetrahedrons were kept (see Fig. 3j). Thus, isolated silicon tetrahedra are still stable up to 24.5 GPa in the KSi compounds. Above 24.5 GPa, P-1-KSi (Z=4) becomes thermodynamically metastable. It has an interesting layered structure consisting of alternating layers of K atoms and Si atoms (Fig. 3k). In the silicon layer, the 4-membered rings share a Si-Si bond with four neighbor congeners, constructing a '4+8'ring pattern (Fig. 4k), in which Si-Si bond lengths are between 2.281 Å and 2.429 Å at 24.5 GPa.

KSi2. The monoclinic C2/m-KSi₂ (Z=4, Fig. 31) is thermodynamically metastable at the range of pressure from 5.0 GPa to 18.5 GPa. Different from the silicon layer

revealed in P-1-KSi, Si atoms in C2/m-KSi₂ polymerize into a novel layer structure, in which the neighbor silicon stripes with 4-membered rings are welded by the shared Si-Si bonds, presenting the wrinkled '4+6' rings pattern (the Si-Si bond lengths are 2.2805Å and 2.4808 Å at 5 GPa. See Fig. 41). Differing from the heavier congener KPb₂ with the hexagonal Laves phase MgZn₂-type structure ⁵¹ (space group $P6_3/mmc$, Z=4) at ambient pressure, the thermodynamically stable KSi₂ crystallized in the cubic Laves phase MgCu₂-type structure ⁵² (space group *Fd*-3*m*, Z=8, Fig. 3m) above 18.5 GPa. In the MgCu₂-type structure of KSi₂, silicon atoms aggregate into the three-dimensional framework structure with the K atoms running through the tunnels (structurally, K atoms form zigzag chains.). The neighboring silicon tetrahedrons are hinged by a shared silicon atom (six-fold coordinated silicon observed, Fig. 4m), constructing a strong covalent network and thus bringing about a strong incompressibility of this system. The pressure-induced structural modification from the monoclinic C2/m structure to the cubic Fd-3m leads to a counter-intuitive chemical bond expansion phenomenon for Si-Si bonds. The Si-Si bond length in *Fd*-3*m* at 18.5 GPa is 2.591 Å which is longer than that in the low-pressure C2/m-KSi₂.

KSi3. The Si-rich C2/m-KSi₃ (Z=4, Fig. 3n) is thermodynamically stable above 2.5 GPa (metastable below 2.5 GPa). Three inequivalent Si atoms locate at three 4*i* sites, forming a wrinkled two-dimension layer with silicon 8-membered rings. At zero pressure, the Si-Si bond length is between 2.416 Å and 2.445 Å (Fig. 4n).

K₈Si₄₆. The known cubic K₈Si₄₆ (space group Pm-3n, Z=1, Fig. 3o) is thermodynamically stable below 17.5 GPa. It belongs to cage-type structures composed

of face-sharing silicon polyhedra of Si₂₀ and Si₂₄, strictly analogous to the well-known gas or liquid hydrates, such as $8Cl_2 \cdot 46H_2O$.³⁶ Two small Si₂₀ cages and six large Si₂₄ cages offer the eight sites for guest K atoms.

C. Electronic properties

To understand the electronic properties of K-Si compounds predicted here, we calculated the electronic band structures and density of states (DOS) (Fig. 5, Fig. S4 and Fig. S5). In the Si-rich systems, all the structures are semiconductors, except for *P*-1-KSi and *Fd*-3*m*-KSi₂. At the K-rich side, all compounds predicted here exhibit some metallicity except *R*-3*m*-K4Si (an indirect gap of 0.68 eV) and *P*-1-K₃Si₂ (a direct gap of 0.59 eV).

From the DOS plots in Fig. 5, we can clearly see a strong hybridization of *s*, *p*, and *d* orbitals of K for all structures, and also a hybridization between K orbitals and Si-*p* orbitals. This is a common feature shared by alkali metal compounds under high pressures. The semiconductivity or metallicity depends on the topology of Si sublattice and K:Si ratio. Due to a much larger electronegativity, Si gains electrons from K. The chemical bonding between Si and K is a mixture of covalency and iconicity, as shown by ELFs in Fig. S6. Between Si atoms, it is of covalent characteristic. In K-rich compounds, Si sublattice needs more electrons from K besides of the limited shared electrons between Si atoms themselves to fill its 3p orbitals; if filled like in *R*-3m-K₄Si, the compound shows semiconducting; otherwise like in I4/m-K₄Si, it will be metallic. And in K-rich compounds, most of them are metallic because the semiconductivity asks for an appropriate Si sublattice under specific K:Si ratio, in order to completely fulfill

Si-*p* orbitals and produce a closed-shell K. The same argument also applies to Si-rich compounds. However, in Si-rich environment, K can be easily stripped off electrons and surrounded by Si sublattice with covalent character like C2/m-KSi₃. Therefore, most Si-rich compounds are semiconductors. *Fd*-3*m*-KSi₂ is metallic because a K-K bonding network exists between Si layers.

In the same stoichiometry, the electronic structure can be subjected to metalsemiconductor changes due to structural evolution and reorganization. The *P*-43*n*-KSi, an indirect semiconductor with a band gap of 1.24 eV at 0 GPa, first transforms into the semiconducting $I4_1/acd$ -KSi at 2.2 GPa (an indirect band gap of 1.31 eV), and then into the semiconducting *C*2/*c* structure at 11 GPa (a direct gap of 1.48 eV). The *C*2/*c*-KSi transforms into the metallic *P*-1-KSi above 24.5 GPa. The *C*2/*m*-KSi₂ is a narrow gap semiconductor with an indirect band gap of 0.23 eV at 5 GPa. Upon compression, the semiconducting *C*2/*m*-KSi₂ transforms into the metallic *Fd*-3*m*-KSi₂ at 18.5 GPa. The *C*2/*m*-KSi₃ holds an indirect band gap of 0.797 eV at 0 GPa. There is also a metalsemiconductor transition in K₄Si, and similarly such a transition was also observed in an isoelectronic compound Ca₂C ¹³. Differing from the two-dimensional metallicity in metallic phase of Ca₂C, *I*4/*m*-K₄Si is a semimetal due to a very small overlap between the bottom of the conduction band and the top of valence band. We also found that *P*-1-K₂Si is a semimetal.

ELF maps the likelihood of finding an electron in the neighborhood space of a reference electron. In order to understand the bonding nature between the atoms in K-Si system, ELFs were calculated and shown in Fig. S6. One can conclude from ELF

plots that all compounds predicted here show obvious ionic characteristics for K-Si bonding, which in nature attributes to the large difference of electronegativity between K atom and Si atom. As Si content increases, we can see the increasing ELF values between Si atoms that signal the strong covalent bonding. Different from the case of Ca-rich carbides in the Ca-C system ¹³, there is no interstitial electron charge accumulation in the K-rich silicides predicted here, indicating that these K-rich compounds are not electrides.

To further explore the potential applications of novel semiconductors predicted here (R-3m-K₄Si, P-1-K₃Si₂, P-43n-KSi, C2/m-KSi₂, and C2/m-KSi₃), we calculated their dielectric properties. From the calculated dielectric functions, we can derive the optical absorption coefficients, which were plotted in Fig. 6. The five predicted compounds exhibit considerably stronger absorption than diamond silicon in the infrared and the visible light range. R-3m-K₄Si has a pronounced absorption peak around 2.5 eV, suggesting that this structure has potential applications in the visible light range.

IV. CONCLUSION

In summary, we have produced the first complete pressure-composition phase diagram for K-Si compounds at pressures up to 30 GPa by performing variablecomposition evolutionary structure searching. K-Si system holds a rich thermodynamic phase diagram and presents a strong structural diversity. Eight novel K-Si compounds were identified and their structural phase transition sequences were also determined. With the increasing Si content, the form of polymerization of silicon atoms has undergone great changes, from the zero dimensional 'isolated' silicon anions to Si dimers to novel Si₄ group (zigzag, quadrangle, or tetrahedron) to one-dimensional chain to two-dimensional layers, and to three-dimensional open structures, presenting dimensional diversity. For two-dimensional silicon layers, silicon exhibits various patterns including '4+8' rings, '4+6' rings, and 8-membered rings, which essentially depends on the K:Si ratio and external pressure so as to overcome the potential barrier. The structural diversity leads to various manifestations of electronic structure, which depend on the form of Si polymerization and K:Si ratio. K-Si bonding shows a character of mixed covalency and iconicity, while Si-Si is of covalent character. Therefore, most compounds in the Si-rich side are semiconductors except for the case when K forms its own bonding network. Semiconducting compounds can also form in the K-rich side only if Si-p orbital is fulfilled and K is left with closed-shell orbitals, which needs simultaneously both an appropriate K:Si ratio and Si polymerization. The excellent optical absorption properties of semiconducting compounds predicted here will evoke their potential applications on the utilization of the solar energy. We believe that the revealed compounds and chemistry in the K-Si system are useful for future works and applications, and that our findings will ignite further experimental and theoretical studies on alkali metal-based IVA compounds.

SUPPLEMENTARY MATERIAL

See supplementary materials for the crystal structures information, phonon dispersion curves, energy band, and electronic localization function of the studied K-Si system.

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Figures and captions



Fig. 1. (Color online) (a) Convex hull diagram for the K-Si system at examined pressures. (b) Pressure-composition phase diagram of the K-Si system. Thick solid lines represent thermodynamically stable phases and dash lines metastable ones (Red lines represent metal and blue lines semiconductor).



Fig. 2. (Color online) Phonon dispersion curves and partial atomic phonon density of states (Phonon DOS) of (a) *I*4/*m*-K₄Si, (b) *R*-3*m*-K₄Si, (c) *C*2/*m*-K₃Si, (d) *R*-3*m*-K₅Si₂, (e) *P*-1-K₂Si, (f) *Cmcm*-K₂Si, (g) *P*-1-K₃Si₂, (h) *P*-43*n*-KSi, (i) *Fd*-3*m*-KSi₂, and (j) *C*2/*m*-KSi₃ at examined pressures.



Fig. 3. (Color online) Crystal structures of K-Si compounds in their stable regions. (a) *I*4/*m*-K₄Si, (b) *R*-3*m*-K₄Si, (c) *C*2/*m*-K₃Si, (d) *R*-3*m*-K₅Si₂, (e) *P*-1-K₂Si, (f) *Cmcm*-K₂Si, (g) *P*-1-K₃Si₂, (h) *P*-43*n*-KSi, (i) *P*-1-KSi, (j) *C*2/*m*-KSi₂, (k) *Fd*-3*m*-KSi₂, (l) *C*2/*m*-KSi₃, (m) *Pm*-3*n*-K₈Si₄₆.



Fig. 4. (Color online) Silicon patterns in the K-Si system. bond lengths is in Å. (a) I4/m-K₄Si at 4GPa, (b) R-3m-K₄Si at 16GPa, (c) C2/m-K₃Si at 6 GPa, (d) R-3m-K₅Si₂ at 9.0 GPa, (e) P-1-K₂Si at 2.5 GPa, (f) Cmcm-K₂Si at 12.8 GPa, (g) P-1-K₃Si₂ at 1 GPa, (h) P-43n-KSi at 0 GPa, (i) P-1-KSi at 24.5 GPa, (j) C2/m-KSi₂ at 5 GPa, (k) Fd-3m-KSi₂ at 18.5 GPa, and (l) C2/m-KSi₃ at 0 GPa.



Fig. 5. (Color Online) Projected density of states of (a) I4/m-K₄Si at 4GPa, (b) R-3m-K₄Si at 16GPa, (c) C2/m-K₃Si at 6 GPa, (d) R-3m-K₅Si₂ at 9.0 GPa, (e) P-1-K₂Si at 2.5 GPa, (f) Cmcm-K₂Si at 12.8 GPa, (g) P-1-K₃Si₂ at 1 GPa, (h) P-43n-KSi at 0 GPa, (i) P-1-KSi at 24.5 GPa, (j) C2/m-KSi₂ at 5 GPa, (k) Fd-3m-KSi₂ at 18.5 GPa, and (l) C2/m-KSi₃ at 0 GPa.



Fig. 6. (Color online) The optical absorption spectrum of five semiconductors: R-3m-K4Si, P-1-

K₃Si₂, P-43n-KSi, C2/m-KSi₂, and C2/m-KSi₃.